

Search Notes

Application/Control No.

10/669,184

Examiner

Alan S. Chen

Applicant(s)/Patent under
Reexamination

LEMKE ET AL.

Art Unit

2182

SEARCHED

Class	Subclass	Date	Examiner
710	9	5/17/05	ASC
	10		
	15		
↓	16		
713	1		
↓	100	↓	↓

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT	5/17/05	ASC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner